

## Flip Chip FBGA

# fcFBGA, fcLGA, fcPoP-MLP, Interposer PoP, Bare Die fcPoP, fcFBGA Hybrid

## **Highlights**

- A complete portfolio of high to low-end fcCSP packages for all mobile applications, including fcFBGA, fcLGA, flip chip package-on-package (bare die PoP and molded laser PoP), interposer PoP, and hybrid flip chip/wirebond solutions
- A leader in the development of a broad range of low cost substrate and process technologies for the cost sensitive mobile and consumer market
- Ultra low flip chip interconnect parasitic eliminates wire inductance and resistance compared to wirebond interconnect
- One piece heat spreader can be added for exceptional thermal performance

## **Features**

- Body sizes 3 x 3mm through 17 x 19mm
- Electroplated Pb-free or Cu pillar bumps
- Bumping capability down to 130µm pitch with lead-free solder and pitch down to 40µm with Cu pillar
- Full service wafer bumping with PBO and PI dielectric options for wafer repassivation and redistribution layer (RDL)
- Molded underfill (MUF) or Capillary underfill (CUF) options
- Uniquely developed fcCuBE® Mass Reflow (MR) process supports bump pitches down to 80μm and below, providing a lower cost alternative to Thermal-Compression Bonding (TCB)
- Thermal-Compression Bonding with Non-conductive Paste (TCNCP) available
- MUF with solder bump and Cu pillar qualified and in production
- 140µm minimum die solder bump pitch in production
- BGA/LGA pitch down to 0.30mm qualified and 0.35mm in production
- Maximum overall height of 1.40mm (fcLFBGA); 1.20mm (fcTFBGA); 1.00mm (fcVFBGA); 0.65mm (fcLGA)
- Minimum Z height fcFBGA hybrid package qualified 0.55mm, and 0.6mm in production
- Conventional 2 to 6 layer through-hole or PPG build-up laminate substrates available; ABF build-up substrates available
- Low cost substrate technology options including Embedded Trace Substrate (ETS), Molded Interconnect Substrate (MIS) in HVM, and Via Under Trace (VUT) qualified, No-Clean Flux and Non-PI Bumping qualified and HVM, and others such as large die CUF and Land Side Cap (LSC) with 0.4mm BGA pitch, Embedded Passive Substrate (EPS) in HVM
- One piece heat spreader option for exceptional thermal performance; fcFBGA-ED-H (1-piece heat spreader) with MUF in high volume production
- Packages assembled in either bare die, exposed die and overmolded strip matrix format, and saw singulated; ultra high density wide strip available



Our fcFBGA packages form a subgroup of the Flip Chip package family of the form factor known as Chip Scale Packages (CSP). Weoffer a complete fcFBGA portfolio of high to low-end leading edge packages for all mobile applications including standard fine pitch fcFBGA packages, hybrid flip chip and fcPoP including Bare Die fcPoP, Interposer POP and Molded Laser PoP (fcPoP MLP).

Our standard fcFBGA packages include very thin profile packages (fcTFBGA, fcVFBGA, fcWFBGA and fcUFBGA), as well as side-by-side die configurations. All fcFBGA packages are produced on substrates with matrix strip format and use overmolding and saw singulation processes similar to wirebond packages of the same form factors. The fcFBGA is an overmolded package with solder balls, and is available in a high thermal performance package (fcFBGA-H) produced on substrates in matrix strip format with heat spreader.

fcFBGA packages are also available in very thin profile hybrid flip chip (flip chip on the bottom and wirebond die on the top) such as fcTFBGA-SD2 and fcTFBGA-SD3. Hybrid fcFBGA packages are available with Mass Reflow (MR), CUF or MUF, and copper (Cu) pillar and Cu wire.

Our fcFBGA offering also includes package-on-package (PoP) solutions in Bare Die and Molded Laser formats. Both fcPoP formats are offered as the bottom PoP package (PoPb) of a stackable flip chip BGA. PoPb is typically an application processor or an integrated baseband device with land pads placed on the top periphery of the package surface to enable the stacking of a second FBGA or PoP top (PoPt) above.

Bare Die PoP differs from fcBGA through the inclusion of memory interface (MI) pads on the substrate top side. Molded Laser PoP (MLP) offers aggressive package height reductions or 0.35mm MI pitch, and, with its overmold configuration, provides better warpage performance. MLP-PoP is also offered with an exposed die (ED) which reduces mold cap height and improved warpage performance.

## **Applications**

We offer a complete fcFBGA portfolio of high to low-end packages for all mobile applications:

- Mobile processors for Smart Phones, Tablets and Wearable Electronic (WE) devices including baseband, application processors, and application processors + baseband
- Chipsets for peripheral IC's driven by demand for high-end Smart Phone functionality, including RFIC, PMIC, Connectivity, Sensors/ MEMS, and Audio CODEC

## **Specifications**

Package Thickness 0.55mm - 1.4mm 250mm - 60mm Die Thickness

Minimum Bump Pitch 130mm, lead-free solder

40mm, Cu pillar

Marking Laser

## Reliability

Moisture Sensitivity Level Temperature Cycling High Temperature Storage Unbiasted HAST

JEDEC Level 3 @ 260°C -55°C/125°C, 1000 cycles (typical) 150°C, 1000 hrs (typical) 130°C, 85% RH, 2 atm, 96 hrs (typical)

#### **Thermal Performance**

Thermal performance is highly dependent on package size, die size, substrate layers and thickness, and solder ball configuration. Simulation for specific applications should be performed to obtain maximum

Package	Body Size (mm)	Pin Count	Die Size (mm)	Thermal Performance ja θ° <b>C/W</b>
fcLFBGA	7 x 7	191	4.46 x 5.65	33.2
fcLFBGA-H*	14 x 14	425	4.9 x 4.9	14.0
fcLGA	13 x 13	144	5.5 x 5.5	27.7
	5 x 6	71	3.8 x 5.0	35.6

Notes: Simulation data for package mounted on 4 layer PCB (per JEDEC JESD51-9) under natural convection as defined in JESD51-2. \*H/S: 0.3mm formed "Hat" type; 100um TIM1 and 100um lid adhesive: 1.75W/mK.

## **Electrical Performance**

Electrical parasitic data is highly dependent on the package layout. 3D electrical simulation can be used on the specific package design to provide the best prediction of electrical behavior. First order approximations can be calculated using parasitics per unit length for the constituents of the signal path. Data below is for a fcLFBGA package, body size 13 x 13mm, 6.0 x 8.0mm die size and frequency of 100MHz.

Length	Inductance (nH)	Capacitance (pF)	Resitance (mΩ)
Self (short)	0.89	0.65	18.3
Mutual	0.24	0.11	
Self (long)	1.78	0.73	32.5
Mutual	0.51	0.12	

Note: Net = Total Trace Length + Via + Solder Ball.

## **Cross Sections**

#### **fcFBGA**

Market: Smart Phone & Tablets AP+BB processors and BB; Chipsets (RFIC, PA, XCVR, PMIC, Connectivity, etc)

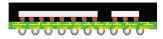
#### **fcVFBGA**

Very thin profile package



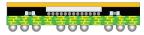
## fcVFBGA-SS2

Very thin profile, 2 die side by side package



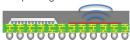
#### fcFBGA-ED-H

Fine pitch, exposed die with heat spreader



#### fcFBGA-AiP

Antenna-in-package for 5G and wireless



#### fcFBGA-AiP (Marsupial)

Antenna-in-package for 5G and wireless



#### **fcPoP**

Market: Smart Phones AP Processors (AP, AP+BB)

#### fcVFBGA-PoP

Very thin profile, bare die PoP



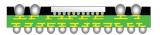
#### fcVFBGA-MLP PoP

Very thin profile, molded laser PoP



#### fcVFBGA MLP PoP-ED

Very thin profile, molded laser, exposed die PoP



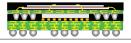
#### fcVFBGA Interposer PoP

Very thin profile, interposer PoP



## fcVFBGA Interposer PoP with TIM

Very thin profile, interposer die PoP



#### **HYBRIDS**

Market: Smart Phones & Wearables BB / Modem; BB + Memory + PMU; MCU/ AP + BT+ Sensors (WE)

#### fcVFBGA-Hybrid w/CUF

Very thin profile hybrid Wirebond - Flip Chip



#### fcWFBGA-Hybrid Fine Pitch Cu Pillar

Very very thin profile hybrid Wirebond - Flip Chip



#### fcVFBGA Hybrid-SS2, Cu wire

Very thin profile, 2 die side by side, stacked hybrid



## fcVFBGA Hvbrid-SS2, Ag wire

Very thin profile, 2 die side by side, stacked hybrid





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